

07/27/07

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Substitute for form 1449/PTO <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(Use as many sheets as necessary)</i>				<b>Complete if Known</b>	
Sheet	1	of	1	Application Number	10/079,286
				Filing Date	February 20, 2002
				First Named Inventor	Peter R. Jepson
				Art Unit	1742
				Examiner Name	L. L. Zheng
				Attorney Docket Number	13194-00163-US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (If known)	MM-DD-YYYY		
/LZ/	AA*	US-6,331,233-B1	12-18-2001	Turner	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (If known)	MM-DD-YYYY		
/LZ/	BA	WO-00/31310-A1	06-02-2000	Cabot Corp	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. \* CITE NO.: Those application(s) which are marked with an single asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. \*Applicant's unique citation designation number (optional). <sup>2</sup>See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
/LZ/	CA	"Conversion Chart for ASTM number vs. grain size in $\mu$ m, based on Table 2 of "Standard Test Methods for Determining Average Grain Size", American Society for Testing and Materials, 1998, E 112,			
/LZ/	CB	"Standard Test Methods for Determining Average Grain Size", American Society for Testing and Materials, 1998, E 112, pp. 1-26.			
/LZ/	CC	FRIEDMAN, G. I., "Grain Size Refinement in a Tantalum Ingot", Metallurgical Transactions, 1971, Vol. 2, No. 1, pp. 337-341.			
/LZ/	CD	CLARK, J. B. et al., "Effect of Processing Variables on Texture and Texture Gradients in Tantalum", Metallurgical Transactions A, 1992, Vol. 22A, pp.2039-2048.			
/LZ/	CE	MUNDEKIS, R. I. et al., "Effects of Rolling Schedule and Annealing on the High Strain Rate Behavior of Tantalum", The Minerals, Metals and Material Society, 1992, pp. 77-96.			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature 547290	/Lois Zheng/	Date Considered	07/31/2007
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